

June 1991 Revised June 2001

#### 74FR2244

# Octal Buffer/Line Driver with 25 $\Omega$ Series Resistors in the Outputs

#### **General Description**

The 74FR2244 is a non-inverting octal buffer and line driver designed to drive capacitive inputs of MOS memory devices, address and clock lines or act as a low undershoot general purpose bus driver.

#### **Features**

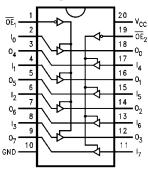
- 3-STATE outputs drive bus lines or buffer memory address registers
- Outputs sink 12 mA and source 15 mA
- $\blacksquare$  25 $\Omega$  series resistors in outputs eliminate the need for external resistors
- Designed to drive the capacitive inputs of MOS devices

#### **Ordering Code:**

Order Number	Package Number	Package Description
74FR2244SC	M20B	20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300" Wide
74FR2244SJ	M20D	20-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74FR2244PC	N20A	20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

#### **Connection Diagram**



#### **Pin Descriptions**

Pin Names	Description				
$\overline{OE}_1, \overline{OE}_2$	Output Enable Input (Active-LOW)				
I <sub>0</sub> –I <sub>7</sub>	Inputs				
$\overline{O}_0 - \overline{O}_7$	Outputs				

#### **Truth Tables**

Inp	uts	Outputs				
OE <sub>1</sub>	I <sub>n</sub>	(Pins 12, 14, 16, 18)				
L	L	L				
L	Н	Н				
Н	Х	Z				

Inp	uts	Outputs		
OE <sub>2</sub>	l <sub>n</sub>	(Pins 3, 5, 7, 9)		
L	L	L		
L	Н	Н		
Н	Х	Z		

H = HIGH Voltage Level

L = LOW Voltage Level

X = Immaterial

Z = High Impedance

#### **Absolute Maximum Ratings**(Note 1)

Storage Temperature  $-65^{\circ}\text{C} \text{ to } +150^{\circ}\text{C}$ 

 $\begin{array}{ll} \mbox{Ambient Temperature under Bias} & -55^{\circ}\mbox{C to } +125^{\circ}\mbox{C} \\ \mbox{Junction Temperature under Bias} & -55^{\circ}\mbox{C to } +150^{\circ}\mbox{C} \\ \end{array}$ 

 $\begin{array}{lll} \text{V}_{\text{CC}} \text{ Pin Potential to Ground Pin} & -0.5 \text{V to } +7.0 \text{V} \\ \text{Input Voltage (Note 2)} & -0.5 \text{V to } +7.0 \text{V} \\ \text{Input Current (Note 2)} & -30 \text{ mA to } +5.0 \text{ mA} \\ \end{array}$ 

Voltage Applied to Output in HIGH State (with  $V_{CC} = 0V$ )

Standard Output  $$-0.5\mbox{V}$ \ to \ \mbox{V}_{\mbox{CC}}$$ 

3-STATE Output -0.5V to +5.5V

Current Applied to Output

in LOW State (Max) Twice the Rated  $I_{OL}$  (mA) ESD Last Passing Voltage (Min) 4000V

## Recommended Operating Conditions

Free Air Ambient Temperature  $0^{\circ}$ C to  $+70^{\circ}$ C Supply Voltage +4.5V to +5.5V

Note 1: Absolute maximum ratings are values beyond which the device

may be damaged or have its useful life impaired.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

#### **DC Electrical Characteristics**

Symbol	Parameter	Min	Тур	Max	Units	V <sub>CC</sub>	Conditions
V <sub>IH</sub>	Input HIGH Voltage	2.0			V		Recognized HIGH Signal
V <sub>IL</sub>	Input LOW Voltage			0.8	V		Recognized LOW Signal
V <sub>CD</sub>	Input Clamp Diode Voltage			-1.2	V	Min	I <sub>IN</sub> = -18 mA
V <sub>OH</sub>	Output HIGH Voltage	2.4			V	Min	I <sub>OH</sub> = -3 mA
		2.0			V	Min	I <sub>OH</sub> = -15 mA
V <sub>OL</sub>	Output LOW Voltage			0.5	V	Min	I <sub>OL</sub> = 1 mA
				0.75	V	Min	I <sub>OL</sub> = 12 mA
I <sub>IH</sub>	Input HIGH Current			5	μΑ	Max	V <sub>IN</sub> = 2.7V
I <sub>BVI</sub>	Input HIGH Current			7	μΑ	Max	V <sub>IN</sub> = 7.0V
	Breakdown Test						
I <sub>IL</sub>	Input LOW Current			-150	μΑ	Max	V <sub>IN</sub> = 0.5V
V <sub>ID</sub>	Input Leakage Test	4.75			V	0.0	$I_{ID} = 1.9 \mu A$
							All Other Pins Grounded
I <sub>OD</sub>	Output Circuit Leakage Current			3.75	μΑ	0.0	V <sub>IOD</sub> = 150 mV
							All Other Pins Grounded
l <sub>OZH</sub>	Output Leakage Current			20	μΑ	Max	V <sub>OUT</sub> = 2.7V
l <sub>OZL</sub>	Output Leakage Current			-20	μΑ	Max	V <sub>OUT</sub> = 0.5V
los	Output Short-Circuit Current	-100		-225	mA	Max	V <sub>OUT</sub> = 0.0V
I <sub>CEX</sub>	Output HIGH Leakage Current			50	μΑ	Max	V <sub>OUT</sub> = V <sub>CC</sub>
I <sub>ZZ</sub>	Bus Drainage Test			100	μΑ	0.0	V <sub>OUT</sub> = 5.25V
I <sub>CCH</sub>	Power Supply Current			40	mA	Max	All Outputs HIGH
I <sub>CCL</sub>	Power Supply Current			70	mA	Max	All Outputs LOW
I <sub>CCZ</sub>	Power Supply Current			46	mA	Max	Outputs 3-STATE

#### **AC Electrical Characteristics**

Symbol	Parameter	$T_A = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_L = 50 \text{ pF}$			$T_{A} = 0^{\circ}C \text{ to } +70^{\circ}C$ $V_{CC} = +5.0V$ $C_{L} = 50 \text{ pF}$		Units
		Min	Тур	Max	Min	Max	•
t <sub>PLH</sub>	Propagation Delay	1.0	2.6	4.4	1.0	4.4	ns
t <sub>PHL</sub>		1.0	1.8	4.4	1.0	4.4	115
t <sub>PZH</sub>	Output Enable Time	2.5	4.8	7.1	2.5	7.1	ns
t <sub>PZL</sub>		2.5	3.9	7.1	2.5	7.1	115
t <sub>PHZ</sub>	Output Disable Time	1.6	3.7	6.4	1.6	6.4	ns
t <sub>PLZ</sub>		1.6	3.6	6.4	1.6	6.4	115

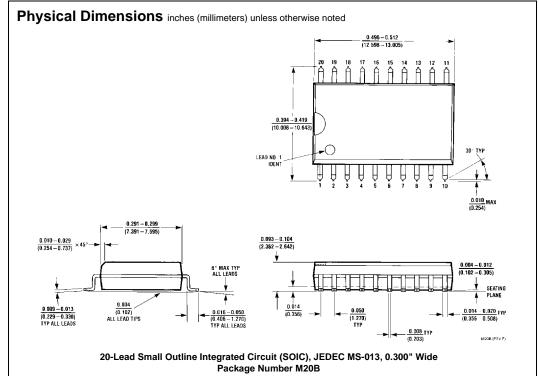
#### **Extended AC Electrical Characteristics**

Symbol	Parameter		V <sub>CC</sub> = C <sub>L</sub> = Eight Outpu	to +70°C - +5.0V 50 pF its Switching ite 3)	$T_A = 0$ °C to $+70$ °C $V_{CC} = +5.0$ V $C_L = 250$ pF (Note 4)		Units
			Min	Max	Min	Max	
t <sub>PLH</sub>	Propagation Delay		1.0	5.9	2.7 9.7		
t <sub>PHL</sub>			1.0	5.9	2.7	9.7	9.7 ns
t <sub>PZH</sub>	Output Enable Time		2.5	8.0			ns
$t_{PZL}$			2.5	8.0			IIS
t <sub>PHZ</sub>	Output Disable Time		1.6	7.0			
$t_{PLZ}$			1.6	7.0			ns
toshl	Pin-to-Pin Skew		1.5				200
	for HL Transitions (Note 5)				1		ns
t <sub>OSLH</sub>	Pin-to-Pin Skew		4.5				
	for LH Transitions (Note 5)			1.5			ns
031	Pin-to-Pin Skew		3.0				ns
	for HL/LH Transitions (Note 5)						

Note 3: This specification is guaranteed but not tested. The limits apply to propagation delays for all paths described switching in phase, i.e., all LOW-to-HIGH, HIGH-to-LOW, 3-STATE-to-HIGH, etc.

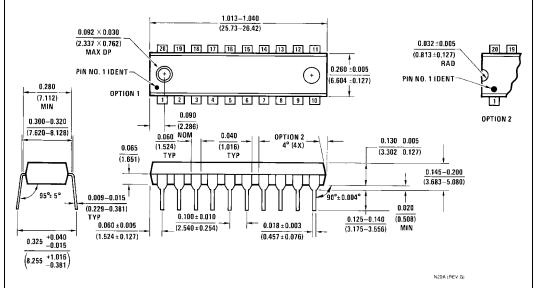
Note 4: These specifications guaranteed but not tested. The limits represent propagation delays with 250 pF load capacitors in place of the 50 pF load capacitors in the standard AC load. This specification pertains to single output switching only.

Note 5: Skew is defined as the absolute value of the difference between the actual propagation delays for any two outputs of the same device. The specification applies to any outputs switching HIGH-to-LOW, (t<sub>OSHL</sub>), LOW-to-HIGH, (t<sub>OSLH</sub>), or HIGH-to-LOW and/or LOW-to-HIGH, (t<sub>OST</sub>). Specifications guaranteed with all outputs switching in phase.



### Physical Dimensions inches (millimeters) unless otherwise noted (Continued) 12.6±0.10 0.40 TYP --A-5.3±0.10 9.27 TYP 7.8 -B-3.9 0.2 C B A ALL LEAD TIPS 10 PIN #1 IDENT.-0.6 TYP 1.27 TYP LAND PATTERN RECOMMENDATION ALL LEAD TIPS SEE DETAIL A 0.1 C 1.8±0.1 -C-L <sub>0.15±0.05</sub> 0.15-0.25 -1.27 TYP 0.35-0.51 ⊕ 0.12 **(** C A DIMENSIONS ARE IN MILLIMETERS GAGE PLANE 0.25 NOTES: A. CONFORMS TO EIAJ EDR-7320 REGISTRATION, ESTABLISHED IN DECEMBER, 1998. B. DIMENSIONS ARE IN MILLIMETERS. C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS. 0.60±0.15 SEATING PLANE 1.25 -M20DRevB1 DETAIL A 20-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide Package Number M20D

#### Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide Package Number N20A

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